

**Search Notes**

Application/Control No.

10/564,955

Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

TERADA, TOMOYASU

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
174	72a	9/2/2006	LEE
✓	68.3	↓	↓
	73.1	↓	↓
174	as above	2/20/2007	LEE
174	as above	8/1/2007	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
174	as above	9/2/2006	LEE
174	as above	8/1/2007	LEE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See text search attached	9/2/2006	LEE
see east search attached	8/1/2007	LEE